Searcn Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/624,932	TAUPIER ET AL.
Examiner	Art Unit
Christopher J. Nichols, Ph.D.	1647

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
SEQ ID NO: 2 residues 163-223	3/10/2005	CJN	
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